

# ASSP

# IF Band

# PLL Frequency Synthesizer

## MB15C101

### ■ DESCRIPTION

The Fujitsu MB15C101 is an exclusive Intermediate Frequency (IF) band Phase Locked Loop (PLL) frequency synthesizer with pulse swallow operation. The reference divider and comparison divider have fixed divide ratios, so that it is not required to set the divide ratios by a microcontroller externally.

It operates with a supply voltage of 3.0 V typ. and dissipates 1.0 mA typ.(270MHz) of current realized through the use of Fujitsu's CMOS technology.

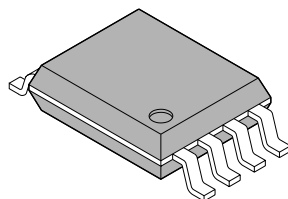
The MB15C101 is ideally suitable for PHS systems.

### ■ FEATURES

- Low power supply current:  $I_{CC} = 1.0 \text{ mA}$  typ. ( $V_{CC} = 3 \text{ V}$ , 270MHz)
- Pulse swallow function; Prescaler: 16/17
- Setting frequency (Selectable by Div input.)
  - $f_{osc} = 19.2 \text{ MHz}$ ,  $f_{IF} = 233.15 \text{ MHz}$  (Div = "H")
  - $f_{osc} = 19.2 \text{ MHz}$ ,  $f_{IF} = 259.20 \text{ MHz}$  (Div = "L")
- Lock detector
- Low power supply voltage:  $V_{CC} = 2.4 \text{ V}$  min.
- Wide operating temperature:  $T_a = -40$  to  $+85^\circ\text{C}$

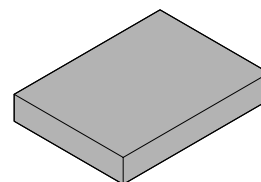
### ■ PACKAGE

8-pin plastic SSOP



(FPT-8P-M03)

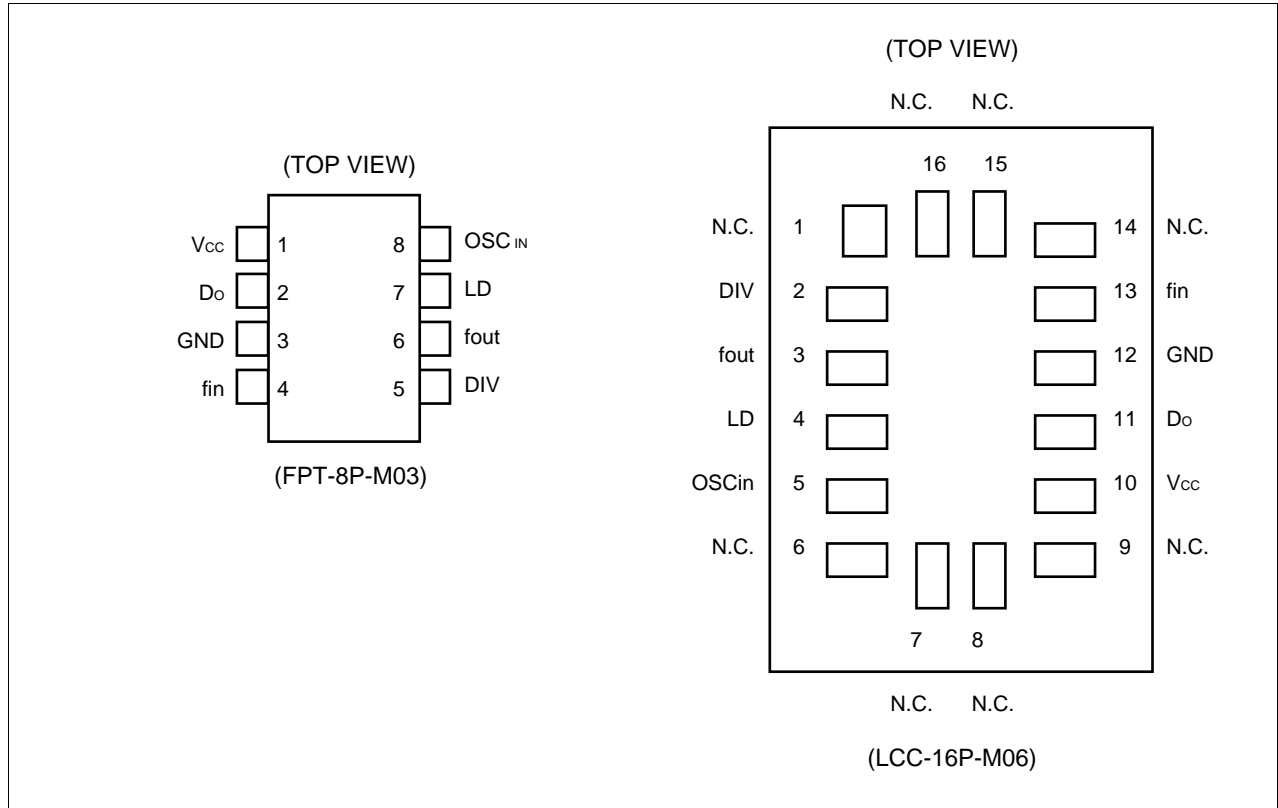
16-pad plastic BCC



(LCC-16P-M06)

# MB15C101

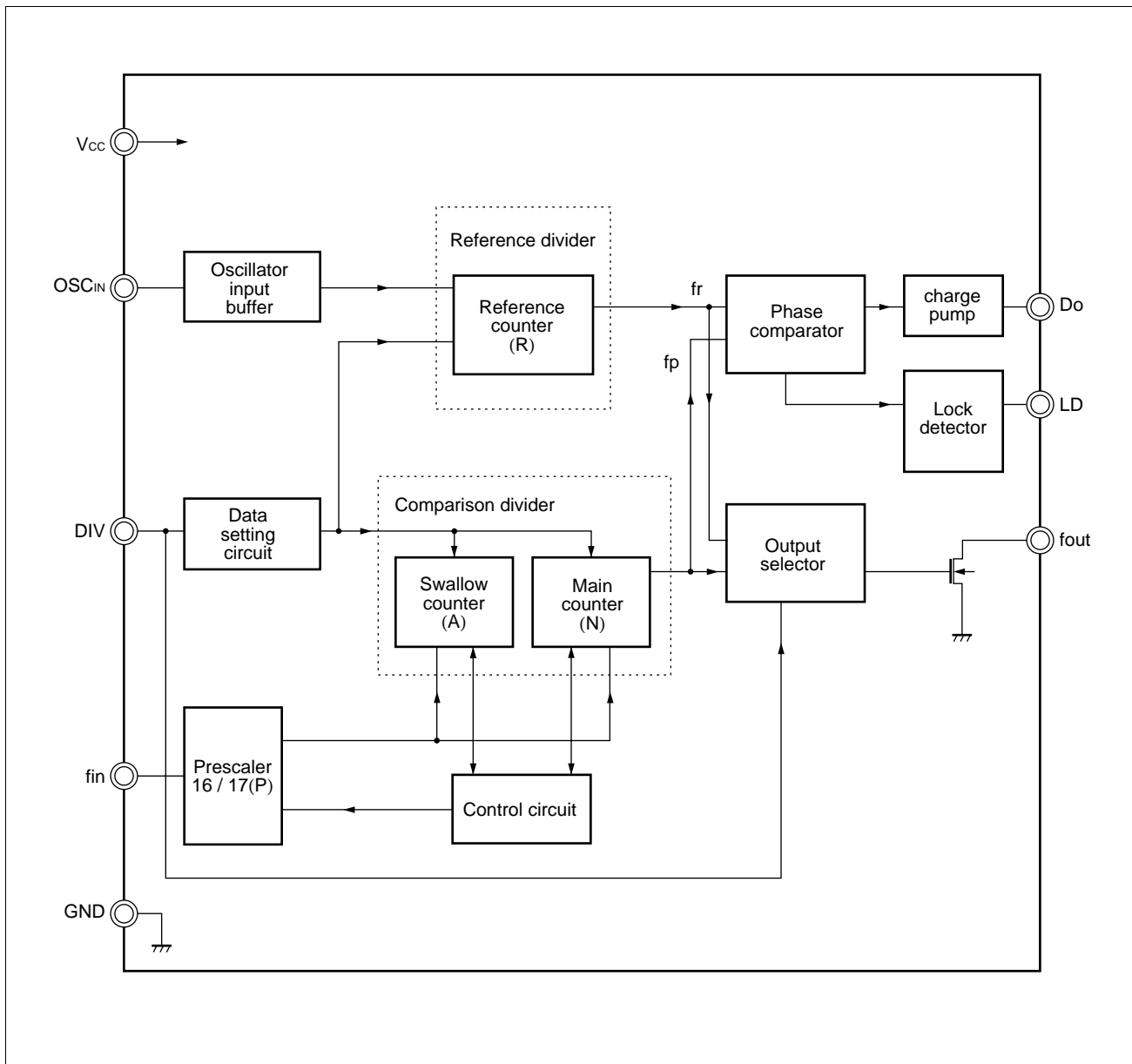
## PIN ASSIGNMENT



## PIN DESCRIPTIONS

Pin No.		Pin name	I/O	Descriptions
SSOP-8	BCC-16			
–	1,6,7,8,9,14,15,16	N.C	–	No connection
1	10	V <sub>CC</sub>	–	Power supply voltage input (2.4 V to 3.6 V).
2	11	D <sub>O</sub>	O	Charge pump output
3	12	GND	–	Ground
4	13	f <sub>in</sub>	I	Prescaler input. Connection should be with AC coupling.
5	2	Div	I	Divide ratio switching input. Two kinds of divide ratios are selectable by Div input “H” or “L”.
6	3	f <sub>out</sub>	O	Test purpose output. This pin is an open drain output so that should be left open usually.
7	4	LD	O	Lock detector output. LD = H ; Lock LD = L ; Unlock
8	5	OSC <sub>in</sub>	I	Reference counter input. Connection should be with AC coupling.

## ■ BLOCK DIAGRAM



## ■ ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Rating		Unit
		Min.	Max.	
Power supply voltage	$V_{CC}$	-0.5	+4.0	V
Input voltage	$V_I$	-0.5	$V_{CC} + 0.5$	V
Output voltage	$V_{OUT}$	-0.5	$V_{CC} + 0.5$	V
Output current	$I_{OUT}$	0	+5	mA
Storage temperature	$T_{STG}$	-55	+125	°C

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

## ■ RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Value			Unit	Note
		Min.	Typ.	Max.		
Power supply voltage	$V_{CC}$	2.4	3.0	3.6	V	
Input voltage	$V_{IN}$	GND	–	$V_{CC}$	V	
Operating temperature	$T_a$	-40	–	+85	°C	

## Handling Precautions

- This device should be transported and stored in anti-static containers.
- This is a static-sensitive device; take proper anti-ESD precautions. Ensure that personnel and equipment are properly grounded. Cover workbenches with grounded conductive mats.
- Always turn the power supply off before inserting or removing the device from its socket.
- Protect leads with a conductive sheet when handling or transporting PC boards with devices.

## ■ ELECTRICAL CHARACTERISTICS

Recommended operating conditions unless otherwise noted.

Parameter		Symbol	Condition	Value			Unit
				Min.	Typ.	Max.	
Power supply current		I <sub>CC</sub>	PLL is locked.(270MHz) V <sub>CC</sub> = 3.0 V, Ta = +25°C	0.1	1.0	2.0	mA
Operating frequency	f <sub>in</sub>	f <sub>in</sub>	AC coupling by 1000 pF capacitor	50	—	270	MHz
	OSC <sub>IN</sub>	f <sub>osc</sub>	AC coupling by 1000 pF capacitor	3	—	26	MHz
Input sensitivity	f <sub>in</sub>	P <sub>f<sub>in</sub></sub>	AC coupling by 1000 pF capacitor	−10	—	+2	dBm
	OSC <sub>IN</sub>	V <sub>osc</sub>	AC coupling by 1000 pF capacitor	0.5	—	—	V <sub>pp</sub>
Input voltage	Div	V <sub>IH</sub>	—	V <sub>CC</sub> × 0.7	—	—	V
		V <sub>IL</sub>	—	—	—	V <sub>CC</sub> × 0.3	V
Input current	Div	I <sub>IH</sub>	—	—	—	1.0	μA
		I <sub>IL</sub>	—	−1.0	—	—	μA
Input current	OSC <sub>IN</sub>	I <sub>OSC</sub>	—	−100	—	100	μA
Output voltage	Do	V <sub>OH</sub>	V <sub>CC</sub> = 3.0 V, I <sub>OH</sub> = −0.3mA	2.6	—	—	V
		V <sub>OL</sub>	V <sub>CC</sub> = 3.0 V, I <sub>OL</sub> = 0.3mA	—	—	0.4	V
Output current	Do	I <sub>OH</sub>	V <sub>CC</sub> = 3.0 V, V <sub>OH</sub> = 2V, Ta = +25°C	—	−6.0	—	mA
		I <sub>OL</sub>	V <sub>CC</sub> = 3.0 V, V <sub>OL</sub> = 1V, Ta = +25°C	—	6.0	—	mA
High impedance cut off current	Do	I <sub>OFF</sub>	0 ≤ V <sub>DO</sub> ≤ V <sub>CC</sub>	—	—	3	nA

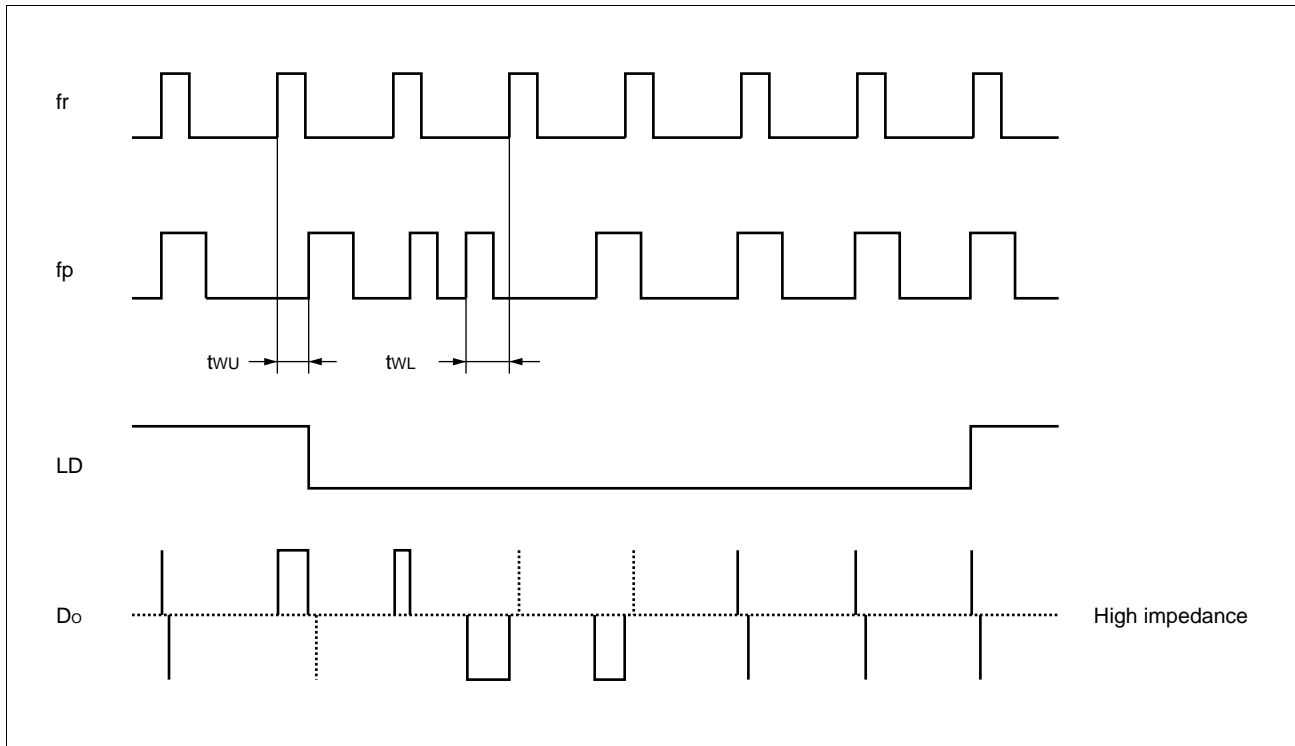
## FUNCTIONAL DESCRIPTIONS

Two different frequencies can be selected by Div input “H” or “L”.  
The divide ratios are calculated using the following equation:

$$f_{VCO} = \{(P \times N) + A\} \times f_{osc} \div R \quad (A < N)$$

Symbol	Description	Div = “H”	Div = “L”
f <sub>VCO</sub>	Output frequency of external VCO	233.15 MHz	259.20 MHz
f <sub>osc</sub>	Reference oscillation frequency	19.2 MHz	19.2 MHz
N	Divide ratio of the main counter	291	33
A	Divide ratio of the swallow counter	7	12
P	Preset divide ratio of dual modulus prescaler	16/17	16/17
R	Divide ratio of the reference counter	384 (fr = 50 kHz)	40 (fr = 480 kHz)

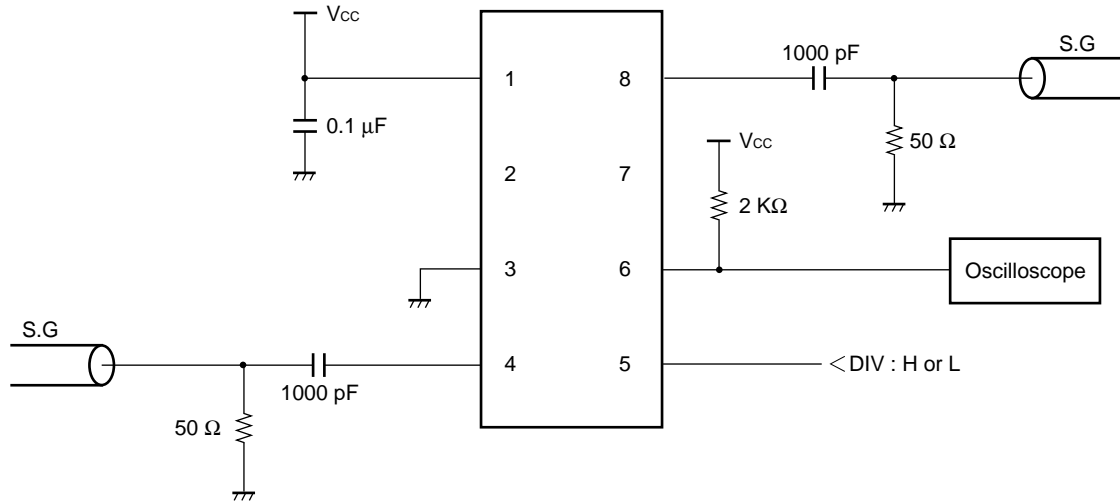
## PHASE DETECTOR TIME CHART



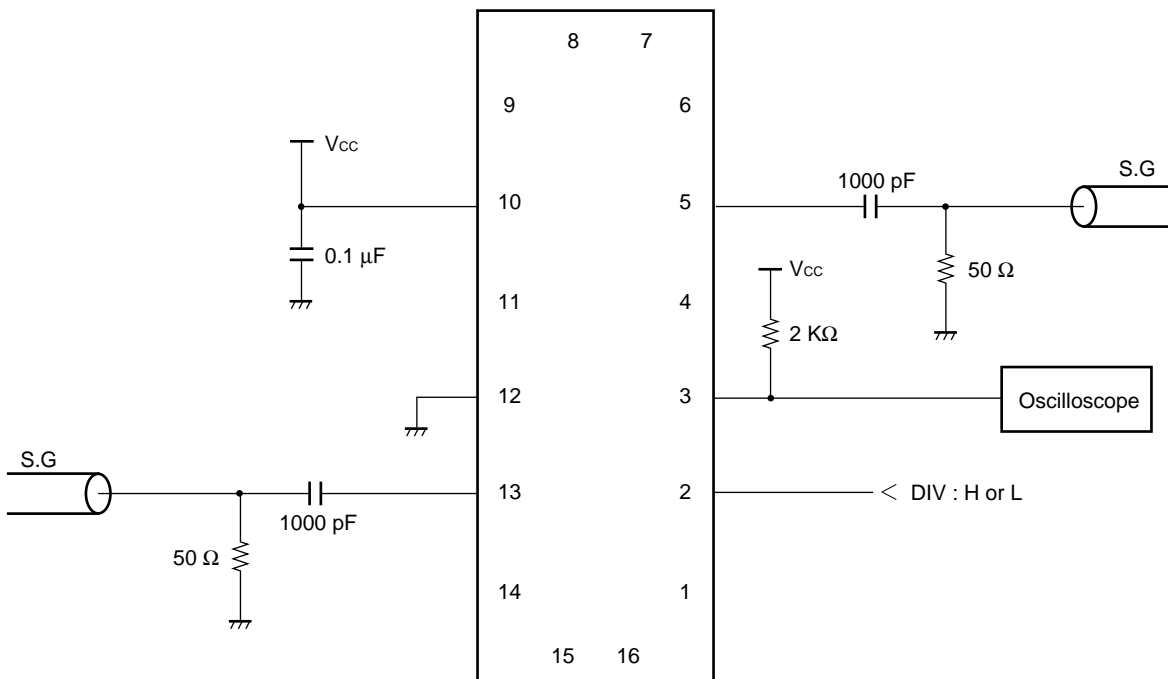
- Note:
- Phase error detection range:  $-2\pi$  to  $+2\pi$
  - Pulses on Do output signal during locked state are output to prevent dead zone.
  - LD output becomes low when phase is  $t_{wu}$  or more. LD output becomes high when phase error is  $t_{wl}$  or less and continues to be so for three cycles or more.
  - $t_{wu}$  and  $t_{wl}$  depend on OSCin input frequency.
    - $t_{wu} \geq 8/f_{osc}$  (s) (e. g.  $t_{wu} \geq 625.0\text{ns}$ ,  $f_{osc} = 12.8\text{ MHz}$ )
    - $t_{wl} \leq 16/f_{osc}$  (s) (e. g.  $t_{wl} \leq 1250.0\text{ns}$ ,  $f_{osc} = 12.8\text{ MHz}$ )

## ■ MEASUREMENT CIRCUIT (for measuring input sensitivity fin/OSCin)

### SSOP-8

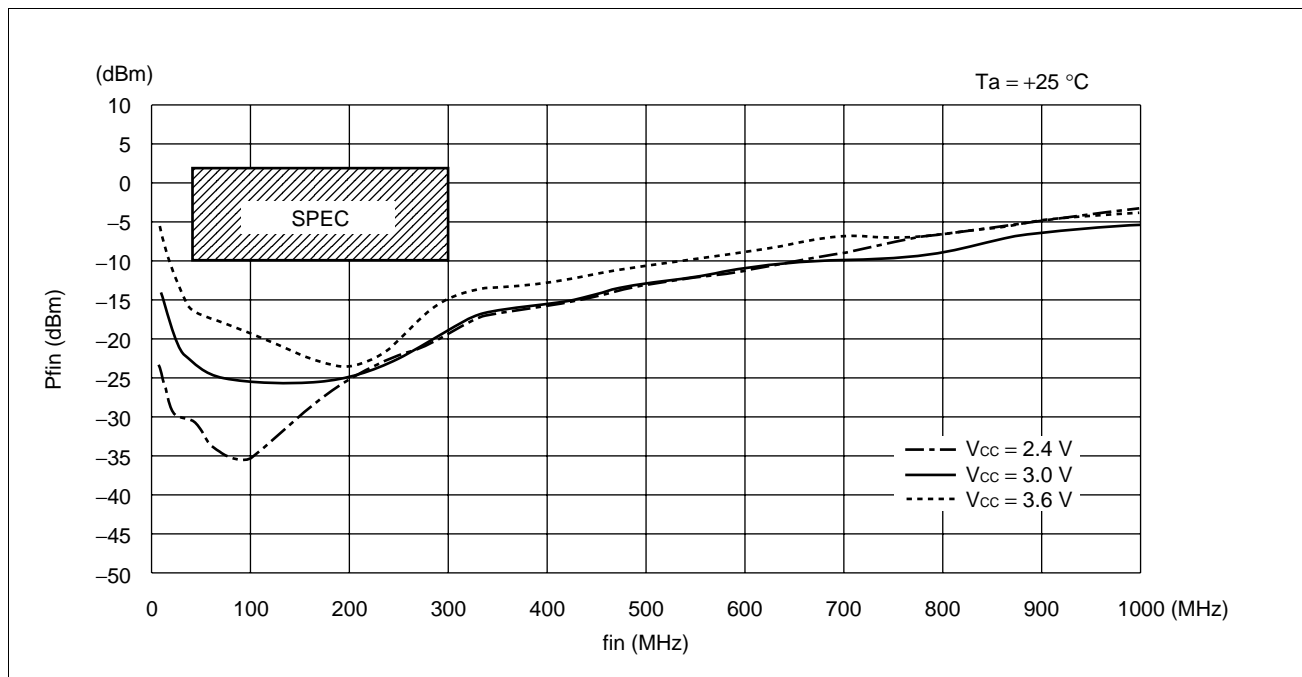


### BCC-16

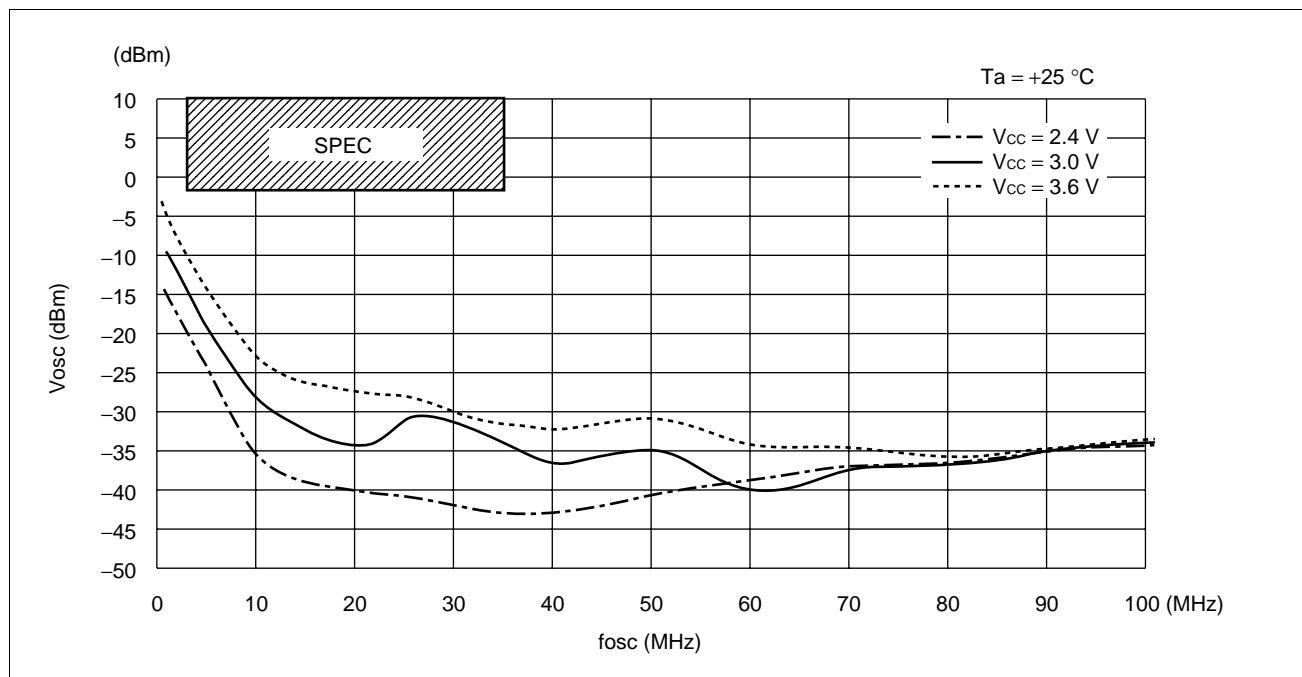


## ■ TYPICAL CHARACTERISTICS

### 1. $f_{in}$ Input Sensitivity

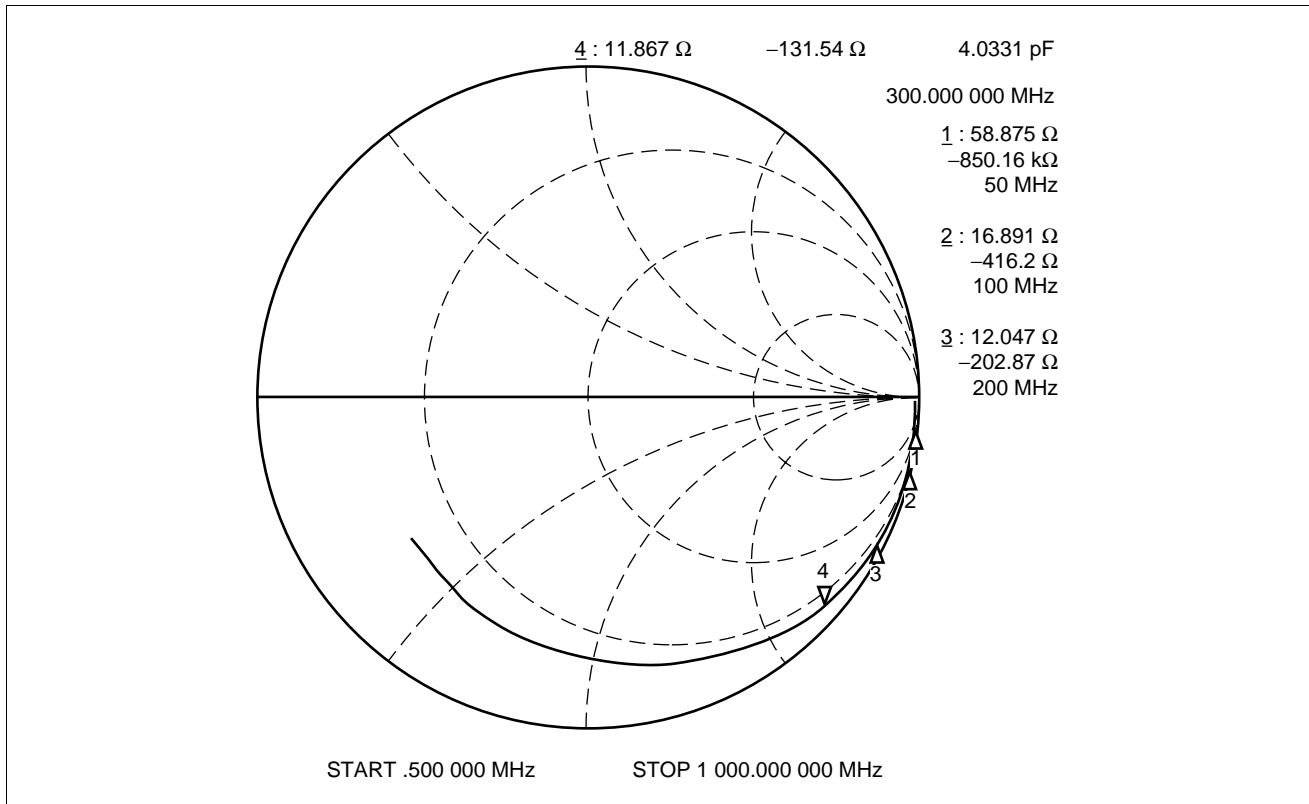


### 2. $OSC_{IN}$ Input Sensitivity

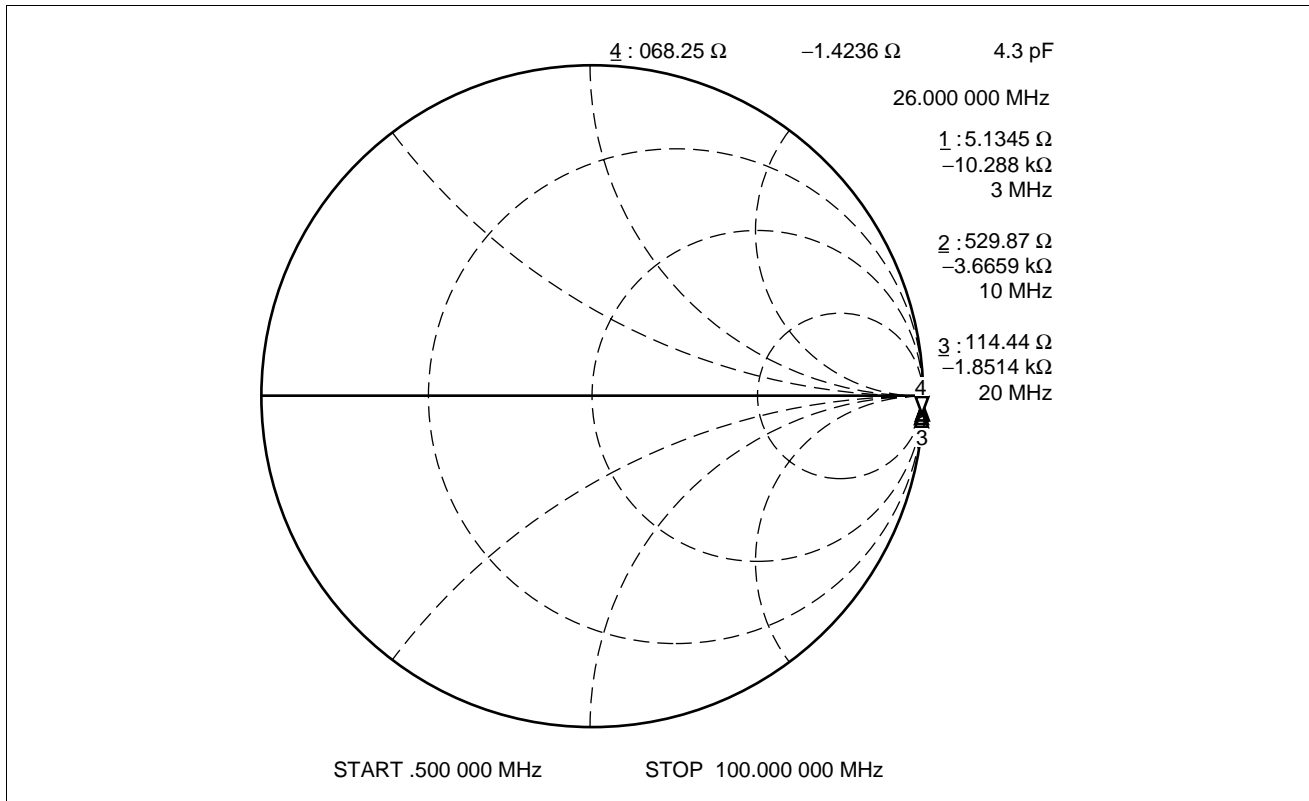




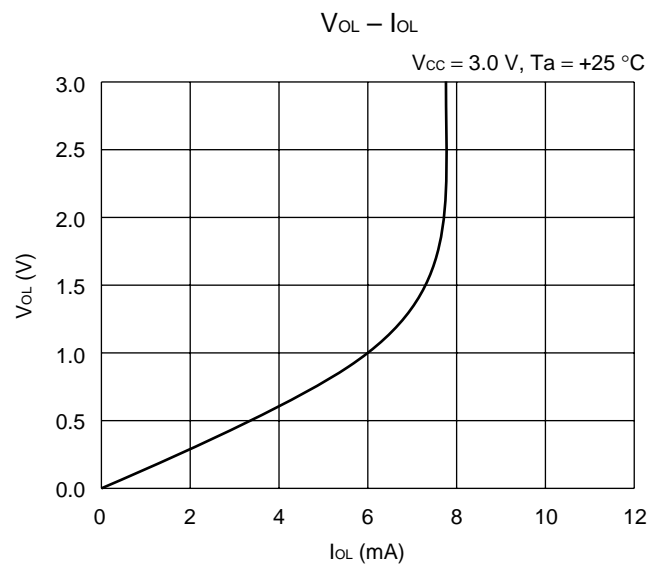
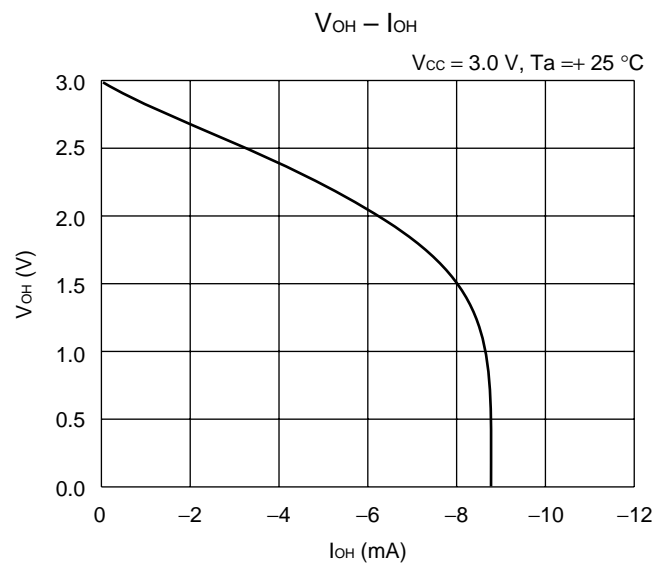
## 3. fin Input Impedance



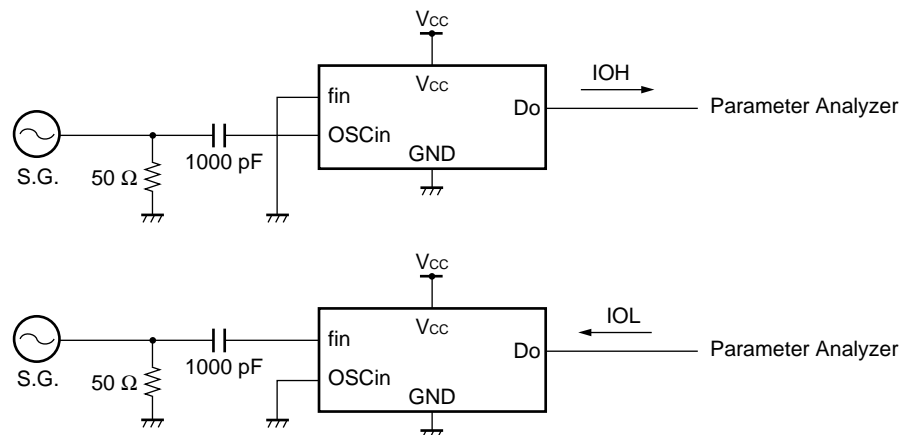
## 4. OSC<sub>IN</sub> Input Impedance



## 5. Do Outut Current



Measurement Circuit



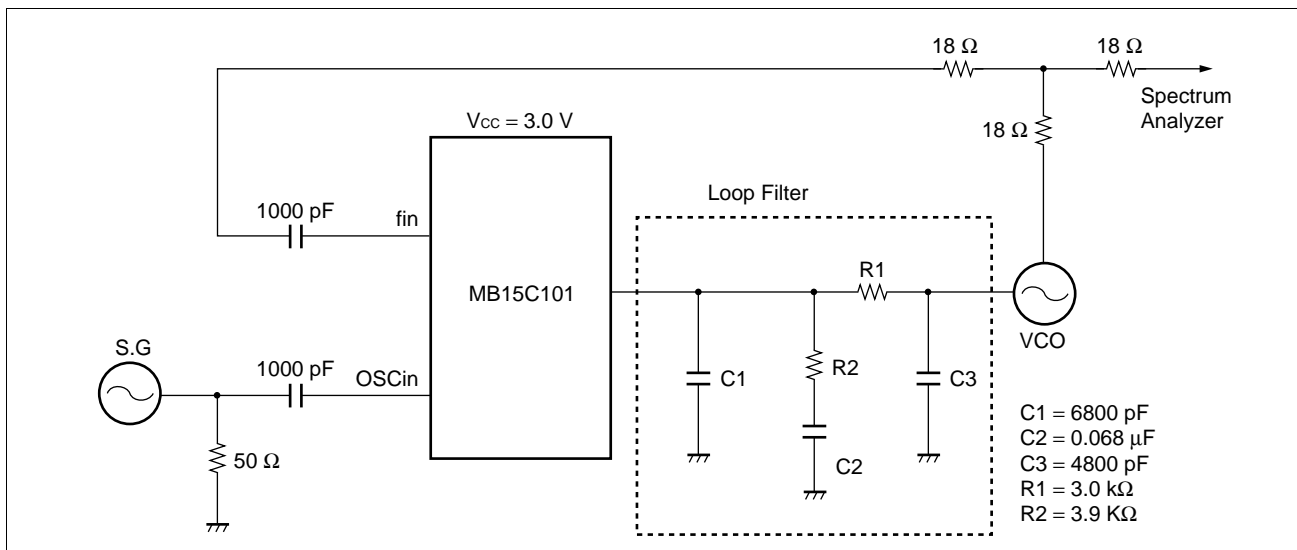
## REFERENCE INFORMATION

### 1. Application Measurement

#### • Test Results

	Results
Lockup time $\pm 1$ kHz Un lock $\rightarrow$ Lock Power on $\rightarrow$ Lock	2.3 ms 3.4 ms
Reference leakage ( $\Delta f = 58$ kHz)	-88.5 dBc
Phase noise ( $\Delta f = 1$ kHz) ( $\Delta f = 10$ kHz) ( $\Delta f = 100$ kHz) ( $\Delta f = 1$ MHz)	-88.0 dBc/Hz -111.0 dBc/Hz -118.0 dBc/Hz -134.0 dBc/Hz
V <sub>CC</sub> (V)	3.0 V
VCO	Discrete VCO ( $K_v = 3.5$ MHz/V) Lock Frequency = 274.0 MHz ( $f_r = 58$ kHz)

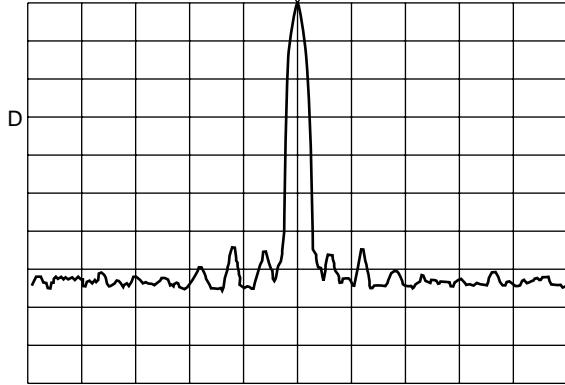
#### • Measurement Circuit



## 2. Phase Noise

$\Delta f = 1 \text{ kHz}$

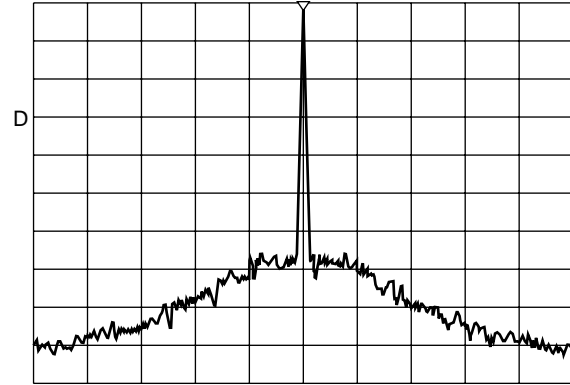
ATTEN 10dB SPAN 2.0 kHz  $\Delta\text{MKR} -73.83 \text{ dB}$   
RL -1.5 dBm 10 dB/ 1.000 kHz



CENTER 273.999827 MHz SPAN 2.000 kHz  
RBW 30 Hz VBW 3.0 Hz SWP 3.00 sec

$\Delta f = 10 \text{ kHz}$

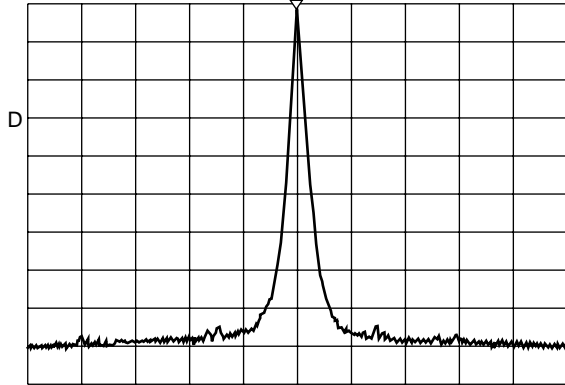
ATTEN 10dB SPAN 20 kHz  $\Delta\text{MKR} -91.83 \text{ dB}$   
RL -1.5 dBm 10 dB/ 10.00 kHz



CENTER 273.999827 MHz SPAN 20.00 kHz  
RBW 100 Hz VBW 30 Hz SWP 30.0 sec

$\Delta f = 100 \text{ kHz}$

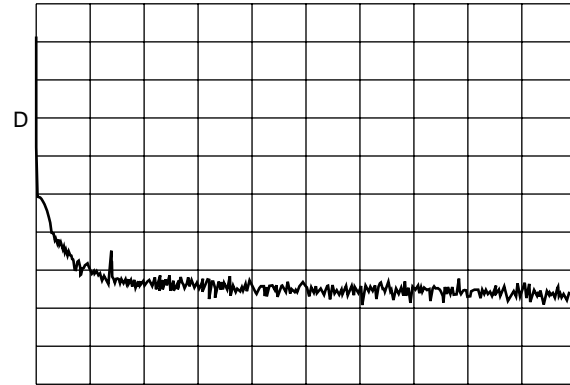
ATTEN 10 dB SPAN 200 kHz  $\Delta\text{MKR} -88.50 \text{ dB}$   
RL -1.5 dBm 10 dB/ 58.0 kHz



CENTER 274.0002 MHz SPAN 200.0 kHz  
RBW 1.0 kHz VBW 30 Hz SWP 30.0 sec

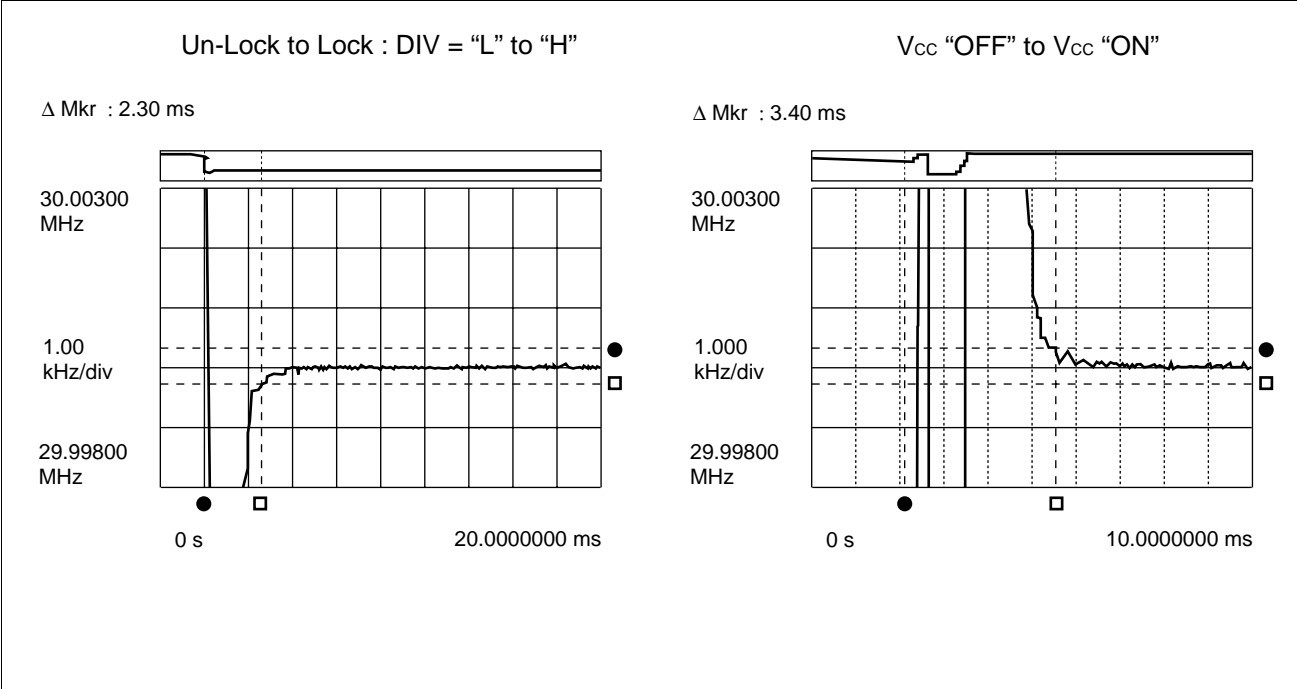
$\Delta f = 1 \text{ MHz}$

ATTEN 10dB SPAN 2 MHz  $\Delta\text{MKR} -105.5 \text{ dB}$   
RL -30.0 dBm 10 dB/ 275.000 MHz



START 274.000 MHz STOP 276.000 MHz  
RBW 1.0 Hz VBW 100 Hz SWP 100 sec

3. Lockup Time: Un-Lock to Lock



# MB15C101

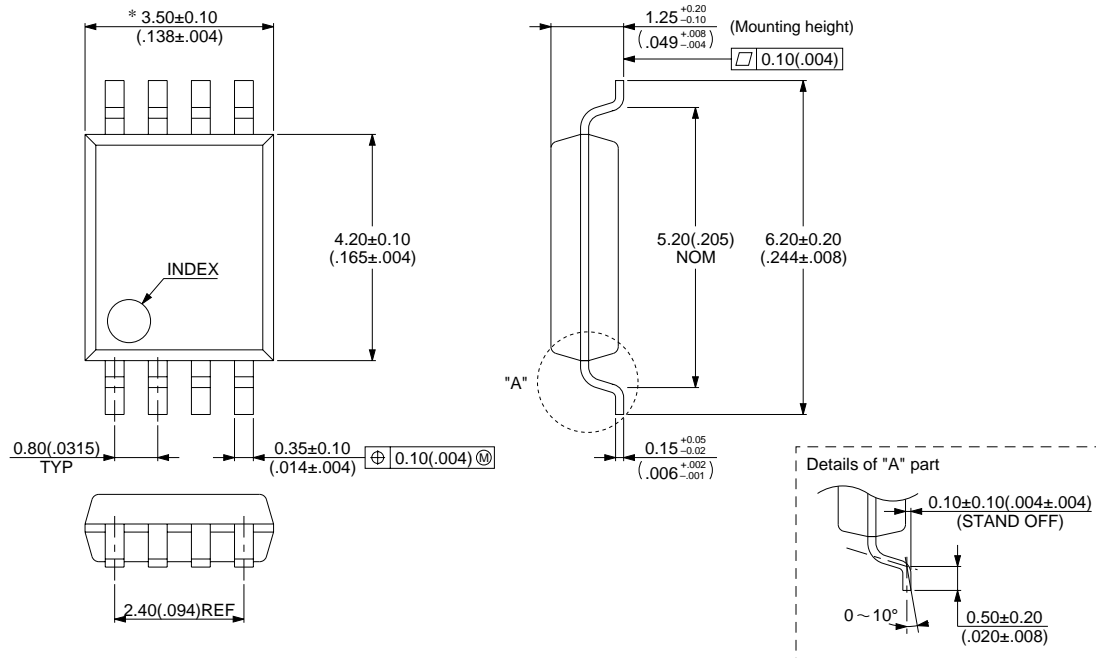
## ■ ORDERING INFORMATION

Part number	Package	Remarks
MB15C101PFV	8-pin, Plastic SSOP (FPT-8P-M03)	
MB15C101PV1	16-pad, Plastic BCC (LCC-16P-M06)	

## ■ PACKAGE DIMENSIONS

8-pin plastic SSOP  
(FPT-8P-M03)

\*: This dimension does not include resin protrusion.



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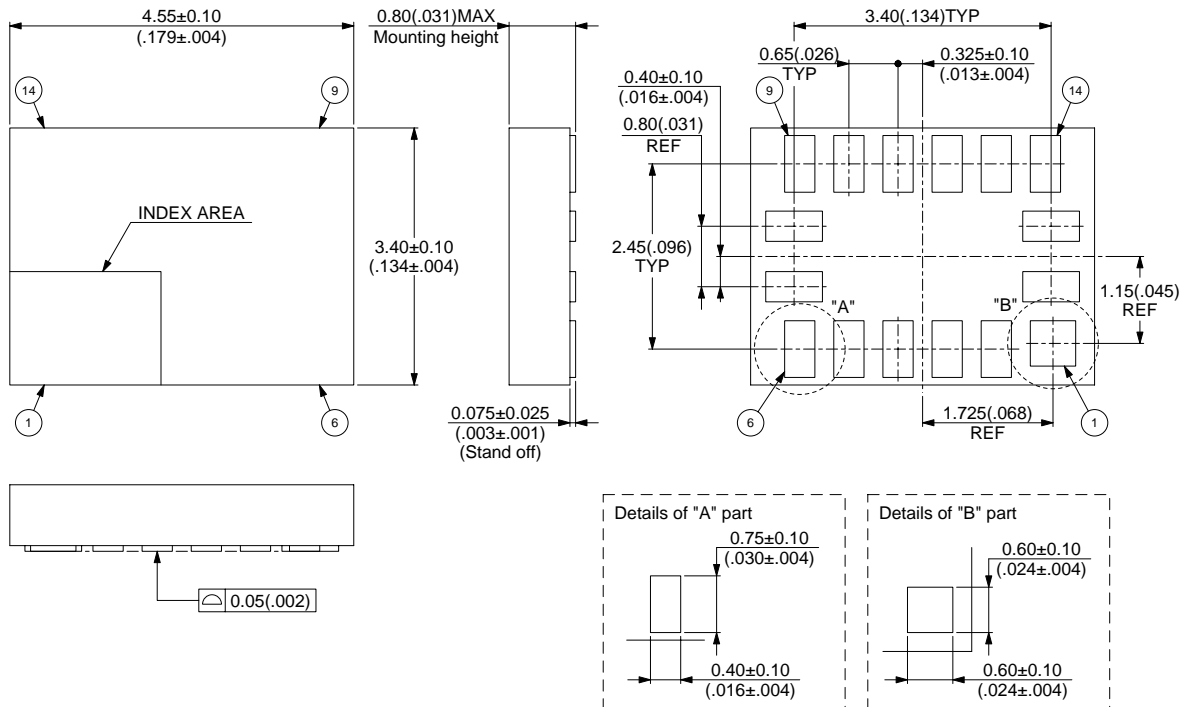
Dimensions in mm (inches)

(Continued)

# MB15C101

(Continued)

## 16-pad plastic BCC (LCC-16P-M06)



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Dimensions in mm (inches)



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